

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

OptiMOSTM

OptiMOS[™] 5 Power-Transistor, 80 V IPT012N08N5

Data Sheet

Rev. 2.1 Final



IPT012N08N5

1 **Description**

Features

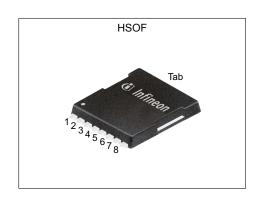
- Ideal for high frequency switching and sync. rec.
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}

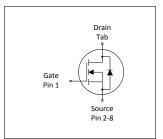
- N-channel, normal level

- 100% avalanche tested
 Pb-free plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target applications
 Halogen-free according to IEC61249-2-21



Table 1 Rey I el lo mance l'alameters							
Parameter	Value	Unit					
V _{DS}	80	V					
R _{DS(on),max}	1.2	mΩ					
I _D	300	A					
Qoss	208	nC					
Q _G (0V10V)	178	nC					











Type / Ordering Code	Package	Marking	Related Links
IPT012N08N5	PG-HSOF-8-1	012N08N5	-





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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

Damamatan	Symbol	Values				
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	- - -	-	300 279 52	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C, $R_{\rm thJA}$ =40 K/W ¹⁾
Pulsed drain current ²⁾	I _{D,pulse}	-	-	1200	Α	T _C =25 °C
Avalanche energy, single pulse ³⁾	E _{AS}	-	-	817	mJ	$I_{\rm D}$ =150 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	375	W	T _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

3 Thermal characteristics

Thermal characteristics Table 3

Parameter	Symbol	Values			Unit	Note / Test Condition
raiailletei	Symbol	Min.	Тур.	Max.	Oilit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	0.2	0.4	K/W	-
Device on PCB, minimal footprint	R _{thJA}	-	-	62	K/W	-
Device on PCB, 6 cm² cooling area ¹⁾	R _{thJA}	-	-	40	K/W	-

 $^{^{1)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air. $^{2)}$ See figure 3 for more detailed information $^{3)}$ See figure 13 for more detailed information



4 Electrical characteristics

Table 4 Static characteristics

Davamatan	0	Values			1114		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA	
Gate threshold voltage	V _{GS(th)}	2.2	3.0	3.8	V	V _{DS} =V _{GS} , I _D =280 μA	
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C	
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	R _{DS(on)}	-	1.0 1.3	1.2 1.7	mΩ	V _{GS} =10 V, I _D =150 A V _{GS} =6 V, I _D =75 A	
Gate resistance ¹⁾	R _G	-	1.6	2.4	Ω	-	
Transconductance	g fs	120	250	-	S	V _{DS} >2 I _D R _{DS(on)max} , I _D =100 A	

Table 5 Dynamic characteristics¹⁾

Baramatar	Cymphal		Values			Nata / Taat Oan dition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C _{iss}	-	13000	17000	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	2000	2600	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Reverse transfer capacitance	C _{rss}	-	86	150	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	35	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.8 Ω
Rise time	t _r	-	31	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.8 Ω
Turn-off delay time	$t_{ m d(off)}$	-	82	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.8 Ω
Fall time	t_{f}	-	30	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.8 Ω

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Table 6 Gate charge characteristics¹⁾

Davamatar	Symbol	Values			11!4	Note / Took Condition
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	56	-	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Gate charge at threshold	Q _{g(th)}	-	38	-	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Gate to drain charge ²⁾	Q _{gd}	-	37	56	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Switching charge	Q _{sw}	-	56	-	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Gate charge total ²⁾	Qg	-	178	223	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.5	-	V	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	154	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V
Output charge ²⁾	Qoss	-	208	276	nC	V _{DD} =40 V, V _{GS} =0 V

Table 7 Reverse diode

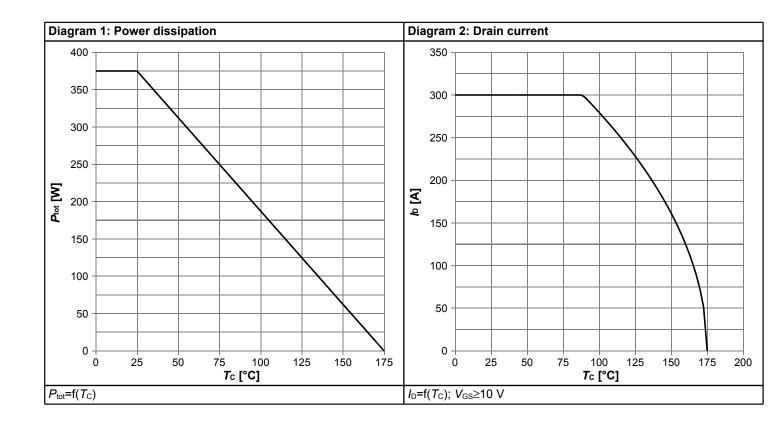
Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailietei	Syllibol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Diode continuous forward current	Is	-	-	300	Α	<i>T</i> _C =25 °C	
Diode pulse current	I _{S,pulse}	-	-	1200	Α	<i>T</i> _C =25 °C	
Diode forward voltage	V _{SD}	-	0.88	1.2	V	V _{GS} =0 V, I _F =150 A, T _j =25 °C	
Reverse recovery time ²⁾	t _{rr}	-	106	212	ns	V _R =40 V, I _F =100A, d <i>i</i> _F /d <i>t</i> =100 A/μs	
Reverse recovery charge ²⁾	Qrr	-	318	636	nC	V _R =40 V, I _F =100A, d <i>i</i> _F /d <i>t</i> =100 A/μs	

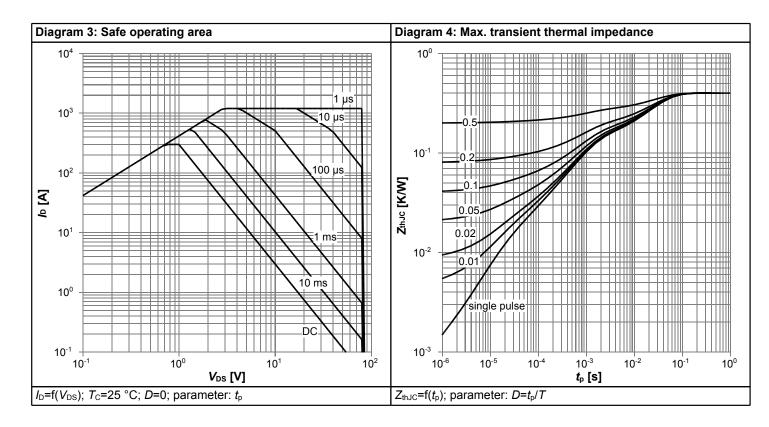
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 $^{^{1)}}$ See "Gate charge waveforms" for parameter definition $^{2)}$ Defined by design. Not subject to production test.

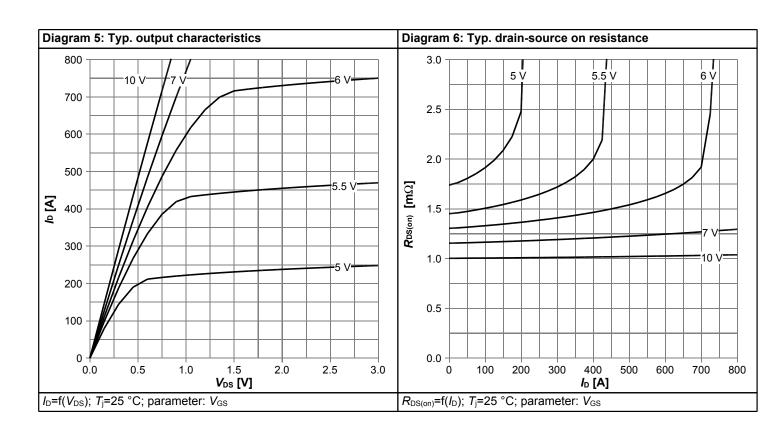


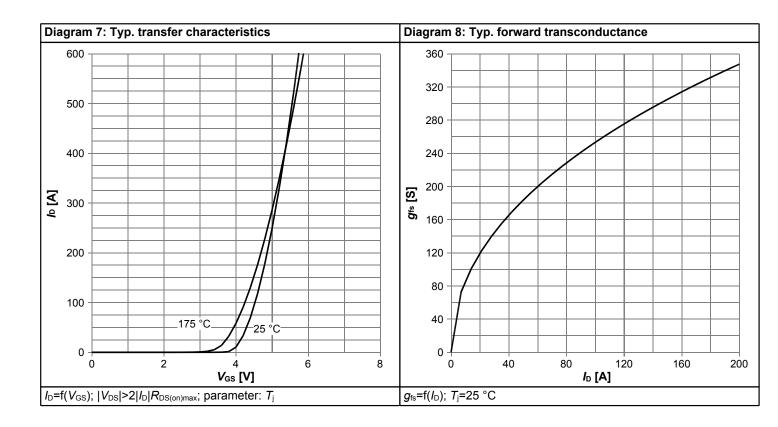
5 Electrical characteristics diagrams



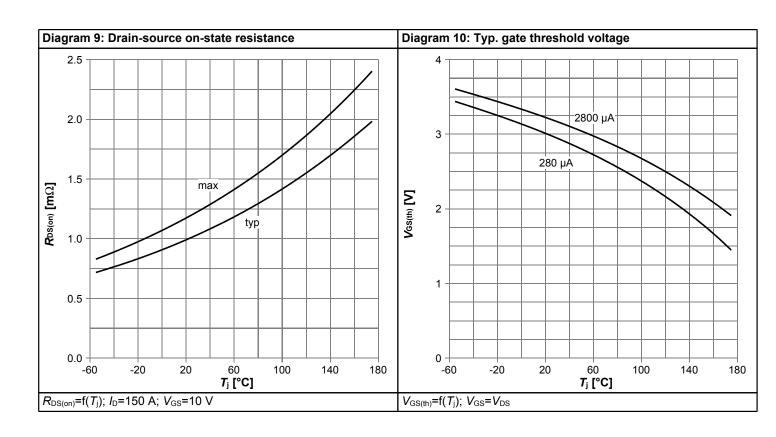


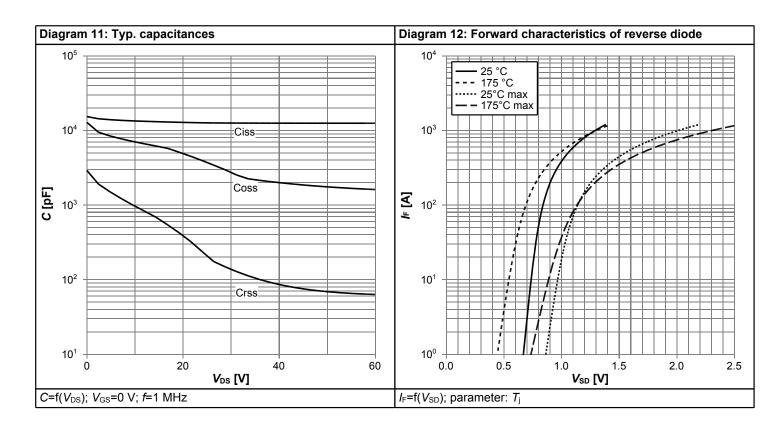




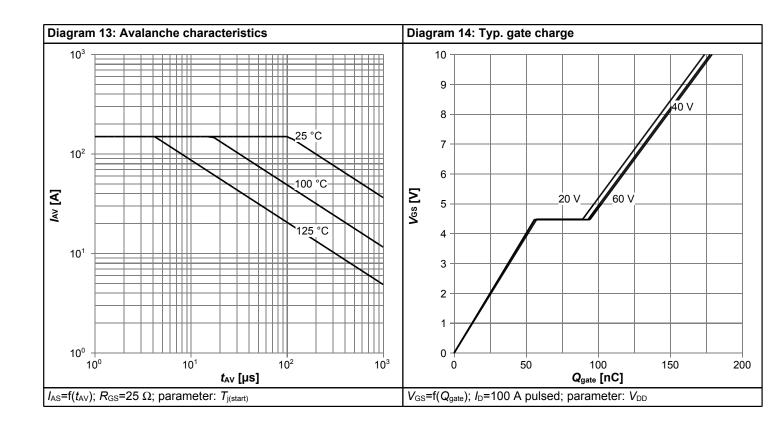


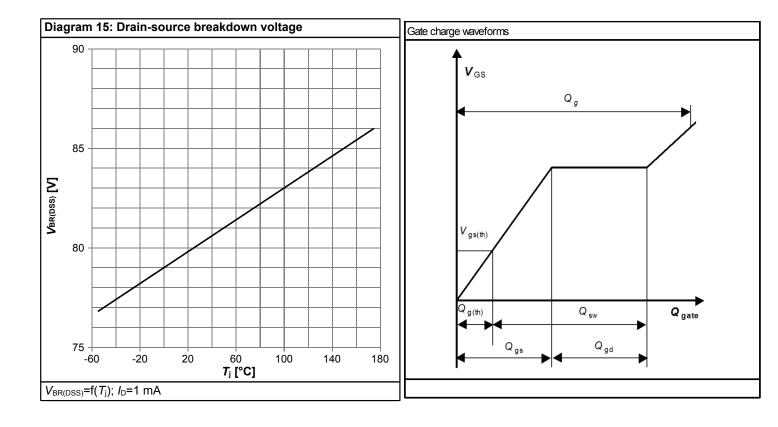














6 Package Outlines

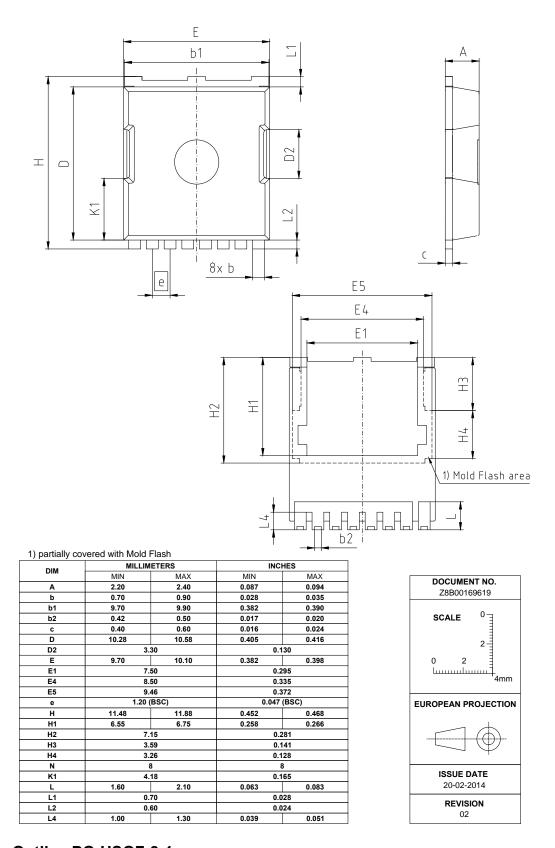


Figure 1 Outline PG-HSOF-8-1



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Revision History

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Revision: 2015-02-23, Rev. 2.1

Previous Revision

FIEVIOUS P	Flevious Revision							
Revision	Date	e Subjects (major changes since last revision)						
2.0	2014-12-17	Release of final version						
2.1	2015-02-23	Update active area about 0.3%						

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